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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANTS	09/309	3,700	41-1	
LIST OF	REFERENCES CITED BY	APPEKANT(S)	3088	HIDEHIKO FUJIMURA, ET AL.				
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		MAY 3 1 20	- 31	U.S. PATENT DOCUMENTS		0.20		
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		OTHER DOCUM	MENT(S)) (Including Author, Title, Date, Pertinent Pages, Etc.)		7		
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANTS HIDEHIKO FUJIMURA, ET AL.					
LIST OF RE	FERENCES CITED BY A se several sheets if neces	APPLICANT(S)	nir.	DENIKO FUJIMUKA	A, EI AL.				
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ign	8-171871	07/1996		Japan				Yes	
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